

August 1998

100313

Low Power Quad Driver

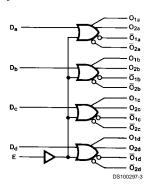
General Description

The 100313 is a monolithic quad driver with two OR and two NOR outputs and common enable. The common input is buffered to minimize input loading. If the D inputs are not used the Enable can be used to drive sixteen 50Ω lines. All inputs have $50~\text{k}\Omega$ pull-down resistors and all outputs are buffered.

Features

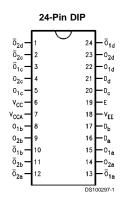
- 50% power reduction of the 100113
- 2000V ESD protection
- Pin/function compatible with 100113 and 100112
- Voltage compensated operating range = -4.2V to -5.7V
- Standard Microcircuit Drawing (SMD) 5962-9673201

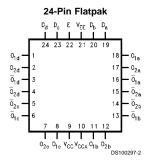
Logic Symbol



Pin Names	Description
D _a -D _d	Data Inputs
E	Enable Input
O _{na} -O _{nd}	Data Outputs
\overline{O}_{na} $-\overline{O}_{nd}$	Complementary Data Outputs

Connection Diagrams





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DS100297

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Storage Temperature (T_{STG}) Maximum Junction Temperature (T_J) -65°C to +150°C

Ceramic

ESD (Note 2)

 V_{EE} Pin Potential to Ground Pin Input Voltage (DC)

-7.0V to +0.5V

Output Current (DC Output HIGH)

 V_{EE} to +0.5V -50 mA

+175°C

≥2000V

Recommended Operating Conditions

Case Temperature (T_C)

Military

–55°C to +125°C

Supply Voltage ($V_{\rm EE}$)

-5.7V to -4.2V

Note 1: Absolute maximum ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: ESD testing conforms to MIL-STD-883, Method 3015.

Military Version DC Electrical Characteristics

 V_{EE} = -4.2V to -5.7V, V_{CC} = V_{CCA} = GND, T_{C} = -55°C to +125°C

Symbol	Parameter	Min	Max	Units	T _C	Cond	Conditions		
V _{OH}	Output HIGH Voltage	-1025	-870	mV	0°C to +125°C				
		-1085	-870	mV	−55°C	V _{IN} =V _{IH (Max)}	Loading with	(Notes 3, 4	
V _{OL}	Output LOW Voltage	-1830	-1620	mV	0°C to +125°C	or V _{IL(Min)}	50Ω to $-2.0V$	5)	
		-1830	-1555	mV	−55°C]			
V _{OHC}	Output HIGH Voltage	-1035		mV	0°C to +125°C				
		-1085		mV	−55°C	V _{IN} =V _{IH (Min)}	Loading with	(Notes 3, 4	
V_{OLC}	Output LOW Voltage		-1610	mV	0°C to +125°C	or V _{IL (Max)}	50Ω to $-2.0\mbox{V}$	5)	
			-1555	mV	−55°C				
V _{IH}	Input HIGH Voltage	-1165	-870	mV	–55°C to +125°C	Guaranteed HIGH Signal		(Notes 3, 4	
						for All Inputs		5, 6)	
V _{IL}	Input LOW Voltage -18		-1475	mV	-55°C to +125°C	Guaranteed LOW Signal		(Notes 3, 4	
						for All Inputs		5, 6)	
I _{IL}	Input LOW Current	0.50		μA	–55°C to +125°C	V _{EE} = -4.2V		(Notes 3, 4	
						$V_{IN} = V_{IL (Min)}$		5)	
I _{IH}	Input HIGH Current								
	Data		350	μΑ	0°C to +125°C				
	Enable		240			$V_{EE} = -5.7V$		(Notes 3, 4	
	Data		500	μA	−55°C	V _{IN} = V _{IH (Max)}		5)	
	Enable		340						
I _{EE}	Power Supply Current	-65	-20	mA	–55°C to +125°C	Inputs Open		(Notes 3, 4 5)	

Note 3: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals -55°C), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 4: Screen tested 100% on each device at -55°C, +25°C, and +125°C, Subgroups 1, 2, 3, 7, and 8.

Note 5: Sample tested (Method 5005, Table I) on each manufactured lot at -55°C, +25°C, and +125°C, Subgroups A1, 2, 3, 7, and 8.

Note 6: Guaranteed by applying specified input condition and testing V_{OH}/V_{OL} .

Military Version AC Electrical Characteristics

 V_{EE} = -4.2V to -5.7V, V_{CC} = V_{CCA} = GND

Symbol	Parameter	T _C =	–55°C	T _C = +25°C		T _C = +125°C		Units	Conditions	Notes
		Min	Max	Min	Max	Min	Max]		
t _{PLH}	Propagation Delay	0.30	2.00	0.30	1.80	0.30	2.30	ns		(Notes 7,
t _{PHL}	Data to Output									8, 10, 11)
t _{PLH}	Propagation Delay	0.50	2.40	0.60	2.30	0.60	2.70	ns	Figures 1, 2	
t_{PHL}	Enable to Output									
t _{TLH}	Transition Time	0.30	2.00	0.30	1.90	0.30	2.00	ns		(Note 10)
t_{THL}	20% to 80%, 80% to									
	20%									

Note 7: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals –55°C), then testing immediately after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

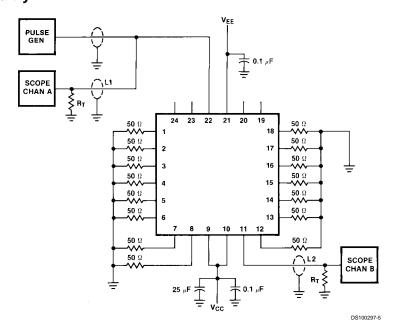
Note 8: Screen tested 100% on each device at +25°C, Subgroup A9.

Note 9: Sample tested (Method 5005, Table I) on each manufactured lot at +25°C, Subgroup A9, and at +125°C and -55°C temperatures, Subgroups A10 and A11.

 $\textbf{Note 10:} \ \ \text{Not tested at } +25^{\circ}\text{C}, \ +125^{\circ}\text{C}, \ \text{and } -55^{\circ}\text{C temperature (design characterization data)}.$

Note 11: The propagation delay specified is for single output switching. Delays may vary up to 150 ps with multiple outputs switching.

Test Circuitry



 V_{CC} , V_{CCA} = +2V, V_{EE} = -2.5V.

L1 and L2 = equal length 50Ω impedance lines.

 R_T = 50 Ω terminator internal to scope.

Decoupling 0.1 μ F from GND to V_{CC} and V_{EE}. All unused outputs are loaded with 50Ω to GND.

C_L = Fixture and stray capacitance ≤ 3 pF.

Pin numbers shown are for flatpak; for DIP see logic symbol.

FIGURE 1. AC Test Circuit

Switching Waveforms

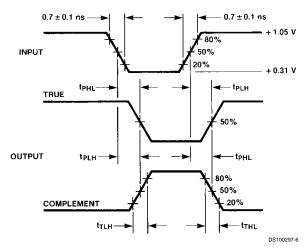
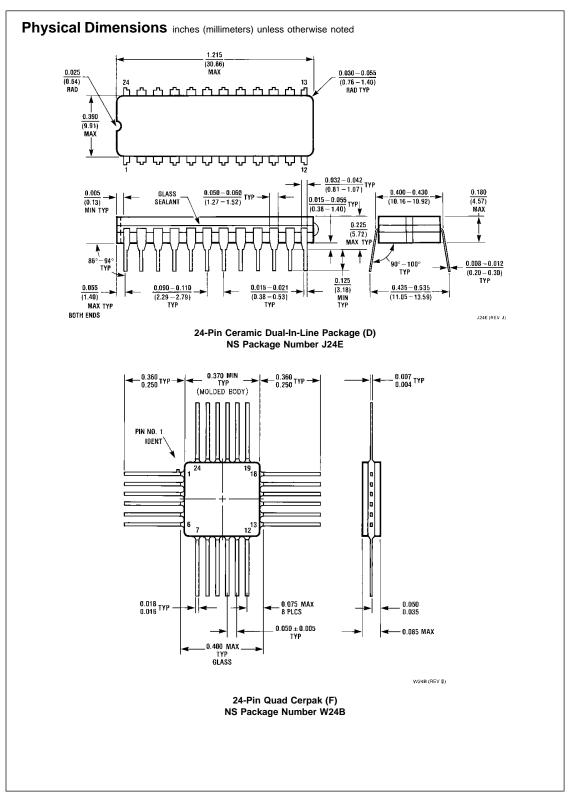


FIGURE 2. Propagation Delay and Transition Times



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Datasheet

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Package Availability, Models, Samples & Pricing

	Package			Models		Samples	Budgeta	Std		
Part Number	Twna	# pins	Status	SPICE	IBIS	& Electronic Orders	Quantity	\$US each	Pack Size	
5962- 9673201QXA	Cerdip	24	Full production	N/A	N/A		50+	\$24.2000	tube of 15	[]c 100 90
5962- 9673201QYA	Cerquad	24	Full production	N/A	N/A	<u>×</u>	50+	\$27.0000	tube of 14	[lo; (F
100313FM- MLS	Cerquad	24	Full production	N/A	N/A		50+	\$260.0000	tube of 14	[lo

[Information as of 4-May-2000]

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